Notice of References Cited Application/Control No. 10/577,225 Examiner Kezhen Shen Applicant(s)/Patent Under Reexamination KATATA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,263,152 B1	07-2001	Hisatomi et al.	386/70
*	В	US-2003/0059205 A1	03-2003	Suzuki, Ryoichi	386/94
*	C	US-2003/0179669 A1	09-2003	Takahashi et al.	369/47.14
*	D	US-2003/0193859 A1	10-2003	Mitsuda et al.	369/47.13
*	Е	US-2004/0042370 A1	03-2004	Sugimura et al.	369/059.25
*	F	US-7,031,239 B2	04-2006	Takahashi et al.	369/47.14
*	G	US-2006/0171281 A1	08-2006	Takahashi et al.	369/053.17
*	Η	US-2006/0171282 A1	08-2006	Takahashi et al.	369/053.17
*	I	US-2007/0081795 A1	04-2007	Katata et al.	386/125
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
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	Т					

NON-PATENT DOCUMENTS

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	*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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